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DEMOUNTABLE CAVITY

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RF SURFACE RESISTANCE OF COPPER-ON-BERYLLIUM AT CRYOGENIC TEMPERATURES MEASURED BY A 22-GHZ DEMOUNTABLE CAVITY

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Abstract

A 22-GHz demountable cavity on the cold head of a compact refrigerator system was used to measure the RF performance of several copper-plated Beryllium samples. The cavity inner surface was treated by chemical polishing and heat treatment, as well as an OFE copper coupon to provide a baseline for comparison. The measured surface resistance was reasonable and repeatable during either cooling or warming. Materials tested included four grades of Beryllium, OFE copper, alumina-dispersion strengthened copper (Glidcop®), and Cu-plated versions of all of the above. Two coupons, Cu-plated on Beryllium O-30 and I-70, offered comparable surface resistance to pure OFE copper or Cu-plated Glidcop. The RF surface resistance of Cu-on-Beryllium samples at cryogenic temperatures is reported together with that of other reference materials.

INTRODUCTION

Beryllium material offers extremely low thermal expansion plus very high thermal conductivity at cryogenic temperatures. High-purity Be also has high electric bulk conductivity at cryogenic temperatures, which suggest that RF performance of bare Beryllium should be high. Past efforts to produce high-performance Be RF surface have failed to meet expectations, whereas measurements of copper on Be at cryogenic temperatures have proven effective. This attempt [1,2] to produce Cu-plated RF surfaces on Be substrate aims to combine the excellent bulk thermal properties of the Be substrate with the good RF properties of copper. If successful, this material should tolerate very high surface power densities and thus can be used in the production of high power RF cavities that do not exhibit thermal distortion. Work with small coupons was performed to allow confirmation of the desired RF performance and development of plating, fabrication, and brazing processes.

EXPERIMENTAL SETUP

The experimental setup is shown in Fig. 1. The cavity itself consists of two components: one is machined out of a block OFE copper, with a cylindrical cavity and a small annular groove on the flat end wall. The other is a replaceable endplate. The dimensions of the cavity are 20.138 mm diameter and 12.454 mm length. The detailed calculation of the cavity modes can be found elsewhere [3]

and the typical values are as follows. At room temperature ($\rho = 1.72 \times 10^{-8} \Omega\text{m}$), the working mode of the cavity is TE_{011} at 21.75 GHz, and the skin depth is 0.448 μm for both TE_{011} and TM_{111} . The groove serves to shift its frequency down from that in an exact pillbox, where TE_{011} mode would be degenerate with two TM_{111} modes. At the middle of the height, the cylinder has two RF ports with loop couplers made of a 50 Ω coaxial line. The couplings are fixed around 1% at room temperature. TM_{111} modes are unexcited by adjusting the loop direction. The advantage of working with TE_{011} mode is that there is no surface current across the annular contact between the test coupon and the cylinder, so that the quality of the contact is not crucial.

The cavity was evacuated with a turbo-molecular pump station through four small holes of 2 mm diameter on the top surface. The typical vacuum was around 10^{-6} Torr before cooling down. The temperature of cavity was monitored with a silicon diode. The resonant frequency was defined as the frequency at which the transmitted power of the network analyzer took the maximum value of the S_{21} coefficient in the scattering matrix. The quality factor Q_L was determined through the half-power points of the S_{21} coefficient. From the S_{11} and S_{22} coefficients, the coupling factors β_1 and β_2 were calculated. The cavity was placed on the cold head of a compact refrigerator system. The lowest temperature achieved was ~ 12 K. A LabView software was developed to automate the

Figure 1: Schematic diagram of experimental setup with a 22 GHz demountable cavity. The network analyzer automatically measured the transmission S_{21} and the reflections S_{11} and S_{22} during either cooling down or warming up.

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measurement, i.e., the unloaded quality factors Q_0 were obtained continuously during cooling down or warming up.

The cavity inner walls and one reference OFE copper coupon were chemically polished (CP) with a mixture of phosphoric acid (85 %), nitric acid (69.8 %) and acetic acid (99.9 %) in a volumetric ratio of 11:4:5. They are then heat treated in a hydrogen furnace at 790 °C for a few minutes. The $Q_{0,Cu}(T)$, or, in the form of $R_{s,Cu}(T)$, as a function of temperature was measured as reference for later comparison. Then the endplate was replaced by the various test coupons.

The surface resistance of the test coupons $R_{s,S}(T)$ at temperature T can be obtained from,

$$\frac{R_{s,S}(T)}{R_{s,Cu}(T)} = k \left(\frac{Q_{0,Cu}(T)}{Q_{0,Cu+S}(T)} - 1 \right) + 1, \quad (1)$$

where k , 4.7737, is the geometrical factor of the cavity.

CUPON PREPARATION

Four different grades of Beryllium substrate have been prepared, S-200FH, S-65, I-70, and O-30. The primary differences between these grades were a) oxide content, and b) means of preparation of the "powder" from which the larger pieces were made (using HIP). For instance, the O-30 was made from "spherical atomized" powder, and I-70 from "impact ground" powder. At least one coupon of each Be substrate candidate was given a 2.5 – 5 μm thick "strike" of Nickel (diffusion barrier) and then plated 100-200 μm with high-purity copper. Bare Be coupons and copper-plated coupons were made from each of these substrate materials.

Table 1. A summary of coupons prepared for testing.

Sample Ser.#	
C1	Pure OFE-copper, chemical polished (CP) and heat treatment
C2	Pure OFE-copper
S1	Stainless steel 304
G1	Cu-plated Glidcop
G3	Glidcop
O-30SN1	Cu-coated on Beryllium
O-30SN3	Bare beryllium
I-70SN1	Cu-coated on Beryllium
I-70SN3	Bare beryllium
S-200FHSN1	Cu-coated Beryllium
S-200FHSN3	Bare Beryllium
S-65SN1	Cu-coated Beryllium
S-65SN3	Bare Beryllium

For baseline comparison, we made coupons from a) 300-series stainless steel, b) OFE copper, and c) Glidcop with and without copper plating.

"OFE copper, ASTM F68 class 2 or better" is specified by LANL for hydrogen furnace brazed RF structures. The relevant factors were that it had to be 99.99% copper and less than 5ppm oxygen. The low-bulk oxygen

content was necessary in order for the material to survive the brazing process without blistering. The hydrogen atmosphere is able to reduce oxides within a short distance of the copper surface without damage to the copper. Therefore, the plating probably does not need to meet the < 5 ppm oxygen specification. Nonetheless, every effort was made to approach the 99.99% purity level in order to obtain acceptable RF surface resistance.

Two Glidcop coupons were prepared with and without copper plating, just for comparison. Cyanide-copper plating was used rather than the typical "bright-acid" type, since the former exhibits fewer problems in hydrogen-furnace brazing. The RF performance of cyanide-copper plating was previously unknown.

The details of the coupon fabrication are reported elsewhere [1]. All coupons we measured are listed in Table 1.

RESULTS

In order to calculate the RF surface resistance of the test coupons, the reference OFE copper endplate C1 was measured first. Figure 2 shows the Q_0 and R_s in the function of temperature. The curves during cooling and warming were consistent with each other.

We repeated the measurement for each of the coupons, as shown in Fig. 3. The surface resistance for G1, Cu-plated Glidcop, was comparable to that of OFE-copper C2 without chemical polishing and heat treatment.

Figure 2. The unloaded quality factors Q_0 and the surface resistance R_s of the reference OFE copper sample as a function of temperature. The crosses ($\times$) and circles ($\circ$) show the data during cooling down and warming up, respectively, and the corresponding R_s are shown with plus (+) and rectangular ($\square$) markers. The solid line shows the surface resistance measured with a mirror-finished cavity at 13.6GHz [4] (the data is scaled to 21.75 GHz by $f^{1/2}$ law). The dashed line near the right vertical axis is the expected Q_0 by calculation, the corresponding surface resistance is indicated by the triangles (Δ).

Figure 3. The R_s for C1, C2, G1, and G2 as a function of temperature together with data of a mirror-finished OFE copper measured elsewhere [4].

Figure 4. The R_s of the Cu-plated on O-30 Beryllium substrate as a function of temperature.

Four pairs of Cu-plated Be and bare Be samples have been measured. One example is shown in Fig. 4. The test coupon is Cu-plated on O-30 Be substrate, and the surface resistance is comparable to OFE copper (C2) over the full temperature range. At 22 GHz, the RF skin depth is less than or equal to the oxide layer thickness on bare Beryllium. Thus, though we tried to measure the bare Be coupons, we were unable to measure the RF properties of metal Be. The measured R_s were erratic and was much worse than the value that would be predicted from the DC electrical bulk resistivity.

EFFECT OF SURFACE ROUGHNESS

We found that the roughness of test coupons has a very significant effect at 22 GHz. The roughness of 8 coupons has been measured, and the average values are listed in Table 2. A typical value of RF skin depth for pure OFE copper at 22 GHz is about 0.448 μm . Although the

coupon C1 surface was treated very carefully with chemical polishing and heat treatment, its average roughness was still 0.163 μm , not small enough if compared to 0.448 μm skin depth. This may explain why the unloaded quality factor was lower than the expected value.

Table. 2: Roughness and surface resistance of measured coupons.

Sample Ser.#	Roughness $R_a(\mu\text{m})$	$R_s(\Omega)$ @ 72 K	$R_s(\Omega)$ @ 293 K
C1	0.163	0.026	0.070
C2	0.83	0.043	0.100
S1		0.347	0.388
G1	0.586	0.044	0.096
G3	0.155	0.078	0.133
O-30SN1	0.632	0.041	0.101
I-70SN1	1.238	0.042	0.109
S-200FHSN1	0.988	0.087	0.208
S-65SN1	0.644	0.168	0.287

The roughness of C2 was much worse than C1. It was clearly shown that the chemical polishing and heat treatment were effective to improve the surface roughness.

SUMMARY

The RF surface resistance as a function of temperature down to ~ 12 K was measured using a 22-GHz TE_{011} mode cavity.

Among four Cu-plated Be coupons, two coupons Cu-plated on Be O-30 and I-70 showed a comparable RF performance to that of the pure OFE copper and the copper-plated Glidcop over the full temperature range. The "cyanide copper" plating method was shown to be acceptable.

Our next step is to perform heat treatment of the copper-plated Be coupons to investigate the stability and RF performance degradation caused by Be/Cu diffusion during braze heat.

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REFERENCES

- [1] R. Wood, Memo LANSCE-1:02-058, August 2002.
- [2] D. Schrage, Memo AT-1:91-384, September 1991.
- [3] S. Kurennoy, Memo LANSCE-1:02-042, September 2002.
- [4] J.-F. Liu, J. Appl. Phys. 87, 3912, (2000).